Complex environment engineering diffractometer (CEED)

Conceptual design update Update of performace characteristics by MC simulations

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New features tested by MC simulations

- Updated neutron guides geometry
- Radial collimators for small gauge volumes
- Double chopper for constant $\Delta\lambda/\lambda$ resolution
- Double frame option
- New virtual samples for "engineering" materials: duplex steel, TiAl alloy

CEED design

a very schematic view ...



CEED design - primary beam



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Double chopper for pulse shaping

fight path



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Double chopper



RESTRAX view of the simulation model

Chopper characteristics

outer radius: 350 mm *frequency:* 140 Hz *window angles:* ~ 54 and 72 deg

distances:

high resolution (HR) 0.2 m ... τ = 50 µs at λ =1 Å

low resolution (LR) 1.0 m ... τ = 250 µs at λ =1 Å

Two choppers operating in "blind" mode: chopper 1 closes when chopper 2 opens - provides flat $\Delta\lambda/\lambda$ – resolution curve

Sample area at 90° configuration



RESTRAX view of the simulation model

Incident beam

free path to the sample: 400 mmvertical: radial collimatoracceptance angle3 degnumber of slits17length:400 mmhorizontal: slit, variable width

Scattered beam

free path to the sample: 400 mm vertical: no collimator acceptance angle 30 deg horizontal: radial collimator acceptance angle 20 deg number of slits 81 length: 800 mm

Sample area at 170° configuration



Incident beam the same as at 90°

Scattered beam

vertical: no collimatoracceptance angle30 deghorizontal: no collimatoracceptance angle10 deg

RESTRAX view of the simulation model

Brilliance transfer to the sample

no radial collimators



Brilliance transfer as a function of wavelength integration volume: $dS = 5 \times 10 \text{ mm}^2$, $d\Omega = 0.3 \times 0.3 \text{ deg}^2$

Time resolution



Nearly constant $\Delta\lambda/\lambda$ resolution as produced by the double chopper for different distances, *dc*=0.2 and *dc*=1.0 m.

Beam width 2 cm => worse resolution at short wavelengths

Gauge volume, $2\theta = 90^{\circ}$



Gauge volume is defined by the **two radial collimators**

Integrated volume: ~ 25 mm³

vertical (before the sample)horizontal (after the sample)

and input slit

free space around the sample: R=400 mm

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Gauge volume, $2\theta = 170^{\circ}$



projection on horizontal plane

Brilliance transfer

including choppers and radial collimators



integration volume: $dS = 3 \times 3 \text{ mm}^2$, $d\Omega = 0.002 \times 0.02 \text{ sr}$

Isotropic scattering



Conversion to d_{hkl} scale is the same as for a powder sample (event based analysis)

Resolution ∆d/d

Simulation with callibration sample (equal F^2 and equidistant d values)



Resolution curves for high and low resolution modes

NOTES:

Resolution includes the contribution of beam divergence, sample size etc. (dominant at high resoluton)

d-range is reduced for the *low resolution* mode due to the penumbra effect

Simulated experiment 1: TiAl

high resolution mode (as described before) two wavelength frames detector range 80 - 100 deg





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Simulated experiment 1: TiAl

comparison of detector angles zoom at low d



detector range 80 - 100 deg

detector range 165 - 170 deg



Simulated experiment 2: duplex steel

comparison of low and high resolution modes zoom at low d



detector range 80 - 100 deg

Summary

- Detailed model of CEED instrument concept is available
- Small gauge volume feasible with radial collimators at ~ 40 cm from the sample (minor loss of intensity)
- Flat $\Delta\lambda/\lambda$ resolution curve, tunable with the double chopper
- Penumbra effect significant reduction of usable bandwidth (mainly at low resolution and high λ) => should the instrument be longer?
- double frame mode: possible, but not easy to configure, avoid cross-talk effects etc.
- tests with virtual samples basis for intercomparisons and testing data analysis in future